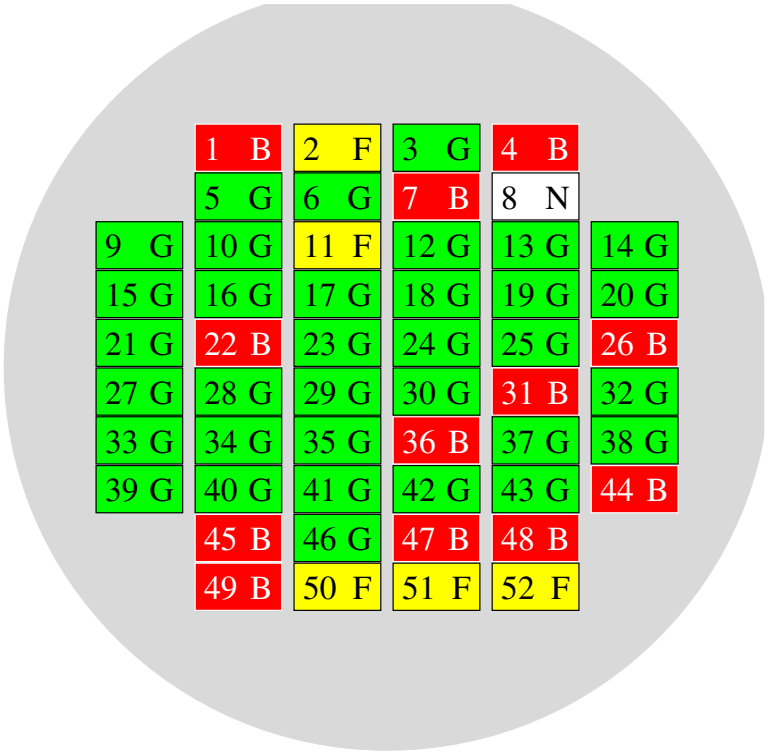
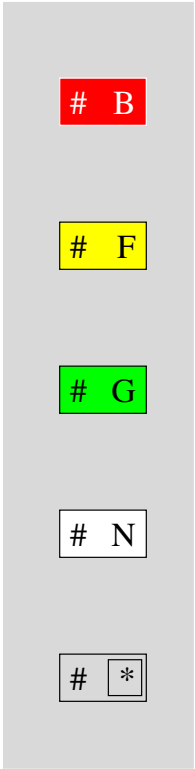
Die quality map for wafer 31 s/n: 21316-06-14 (not backplated)

Date: 11/02/98





Bad die

Fair die

Good die

No info

Manually tagged